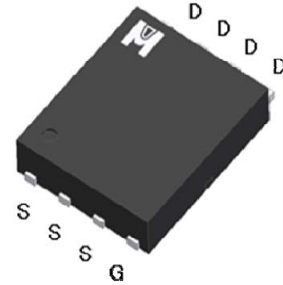


N-Channel Logic Level Enhancement Mode Field Effect Transistor

Product Summary:

$BV_{DSS}$	20V
$R_{DS(on)}$ (MAX.)	30m $\Omega$
$I_D$	10A



Pb-Free Lead Plating & Halogen Free



ABSOLUTE MAXIMUM RATINGS ( $T_C = 25^\circ\text{C}$  Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNIT
Gate-Source Voltage		$V_{GS}$	$\pm 12$	V
Continuous Drain Current	$T_C = 25^\circ\text{C}$	$I_D$	10	A
	$T_C = 70^\circ\text{C}$		7	
Pulsed Drain Current <sup>1</sup>		$I_{DM}$	40	
Power Dissipation	$T_C = 25^\circ\text{C}$	$P_D$	25	W
	$T_C = 70^\circ\text{C}$		16	
Operating Junction & Storage Temperature Range		$T_{j}, T_{stg}$	-55 to 150	$^\circ\text{C}$

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNIT
Junction-to-Case	$R_{\theta JC}$		5	$^\circ\text{C}/\text{W}$
Junction-to-Ambient <sup>3</sup>	$R_{\theta JA}$		62	

<sup>1</sup>Pulse width limited by maximum junction temperature.

<sup>2</sup>Duty cycle  $\leq 1\%$

<sup>3</sup>62 $^\circ\text{C}/\text{W}$  when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.

ELECTRICAL CHARACTERISTICS ( $T_A = 25\text{ }^\circ\text{C}$ , Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
<b>STATIC</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	20			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	0.45	0.75	1.2	
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0V, V_{GS} = \pm 12V$			$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 16V, V_{GS} = 0V$			1	$\mu A$
		$V_{DS} = 16V, V_{GS} = 0V, T_J = 125\text{ }^\circ\text{C}$			10	
On-State Drain Current <sup>1</sup>	$I_{D(ON)}$	$V_{DS} = 5V, V_{GS} = 4.5V$	10			A
Drain-Source On-State Resistance <sup>1</sup>	$R_{DS(ON)}$	$V_{GS} = 4.5V, I_D = 5A$		26	30	m $\Omega$
		$V_{GS} = 2.5V, I_D = 4A$		45	51	
Forward Transconductance <sup>1</sup>	$g_{fs}$	$V_{DS} = 5V, I_D = 5A$		7		S
<b>DYNAMIC</b>						
Input Capacitance	$C_{iss}$	$V_{GS} = 0V, V_{DS} = 10V, f = 1MHz$		280		pF
Output Capacitance	$C_{oss}$			47		
Reverse Transfer Capacitance	$C_{rss}$			38		
Total Gate Charge <sup>1,2</sup>	$Q_g$	$V_{DS} = 10V, V_{GS} = 4.5V, I_D = 5A$		6.2		nC
Gate-Source Charge <sup>1,2</sup>	$Q_{gs}$			0.9		
Gate-Drain Charge <sup>1,2</sup>	$Q_{gd}$			2.1		
Turn-On Delay Time <sup>1,2</sup>	$t_{d(on)}$	$V_{DS} = 10V, I_D = 1A, V_{GS} = 4.5V, R_{GS} = 6\Omega$		12		nS
Rise Time <sup>1,2</sup>	$t_r$			15		
Turn-Off Delay Time <sup>1,2</sup>	$t_{d(off)}$			30		
Fall Time <sup>1,2</sup>	$t_f$			13		
<b>SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (<math>T_C = 25\text{ }^\circ\text{C}</math>)</b>						
Continuous Current	$I_S$				10	A
Pulsed Current <sup>3</sup>	$I_{SM}$				40	
Forward Voltage <sup>1</sup>	$V_{SD}$	$I_F = I_S, V_{GS} = 0V$			1.2	V

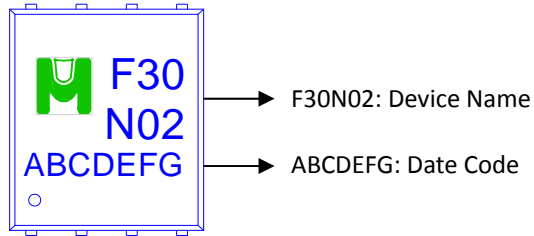
<sup>1</sup>Pulse test : Pulse Width  $\leq 300\ \mu\text{sec}$ , Duty Cycle  $\leq 2\%$ .

<sup>2</sup>Independent of operating temperature.

<sup>3</sup>Pulse width limited by maximum junction temperature.

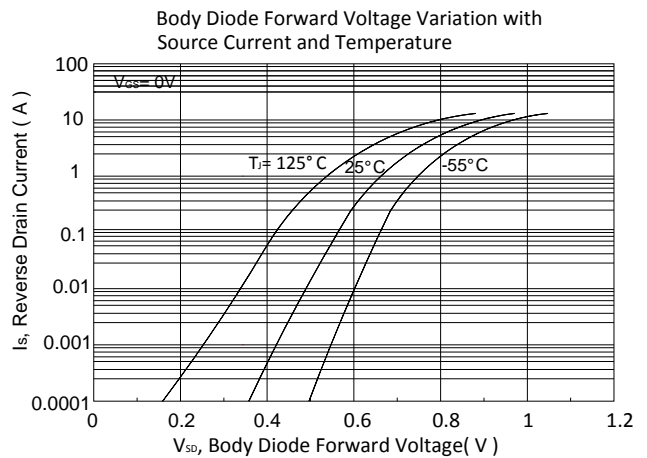
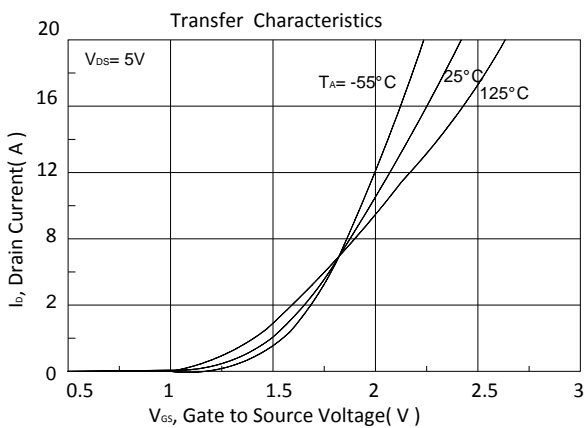
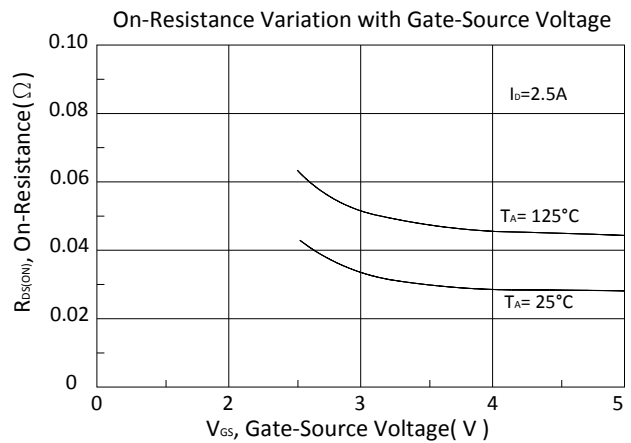
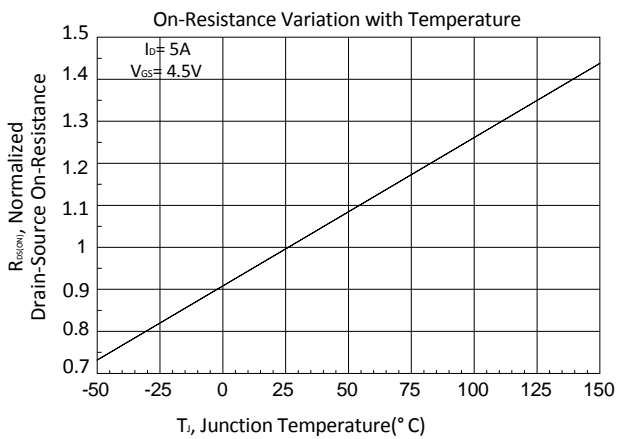
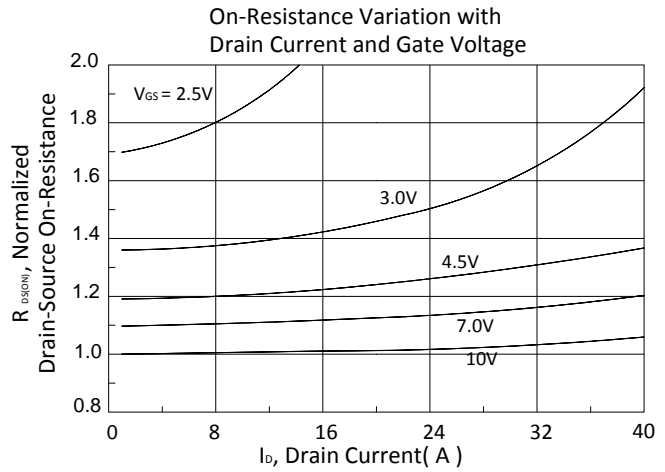
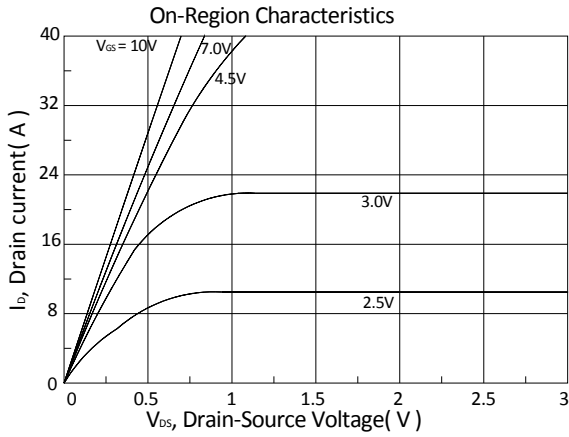
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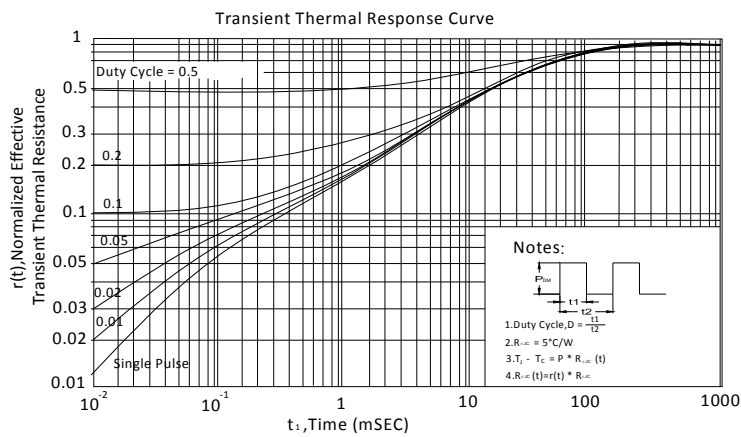
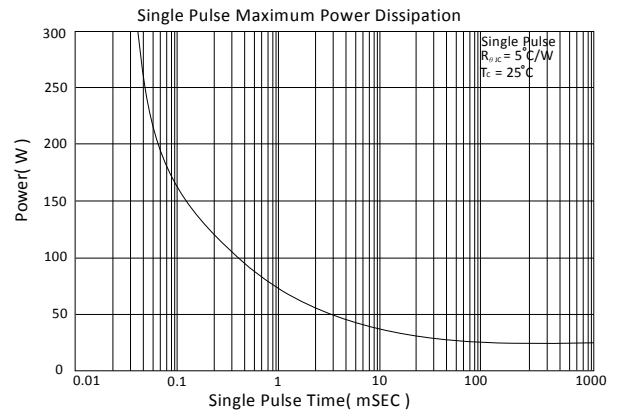
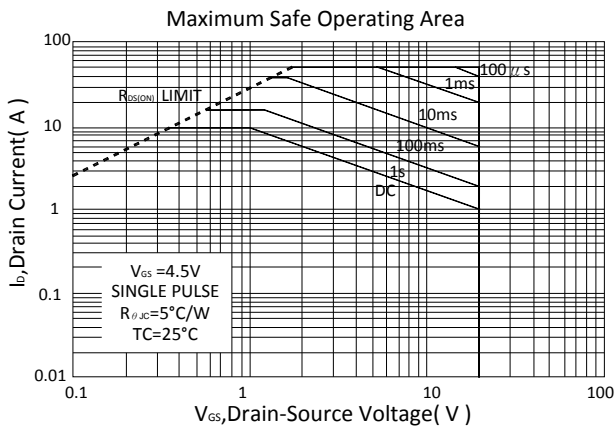
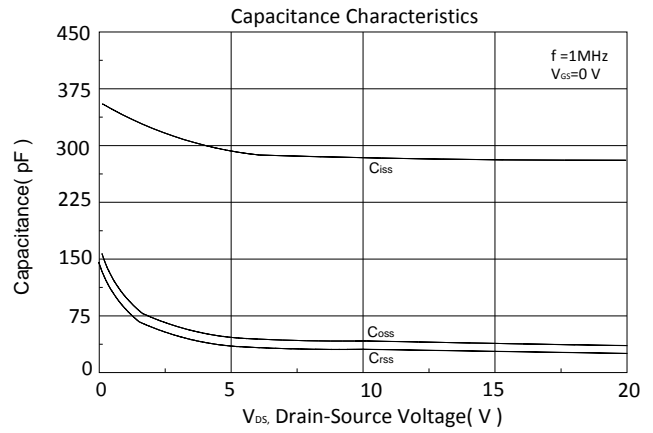
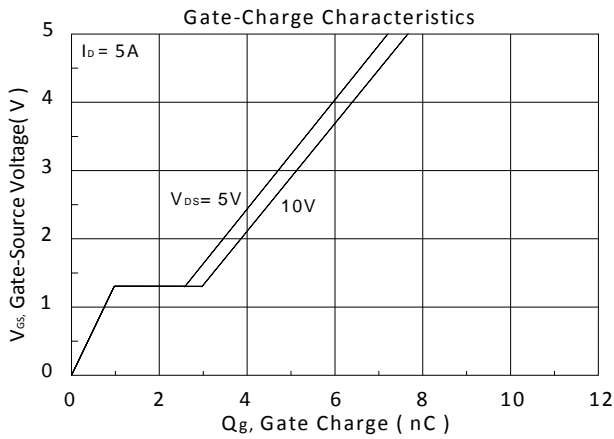
Device Name: EMF30N02H for EDFN 5 x 6





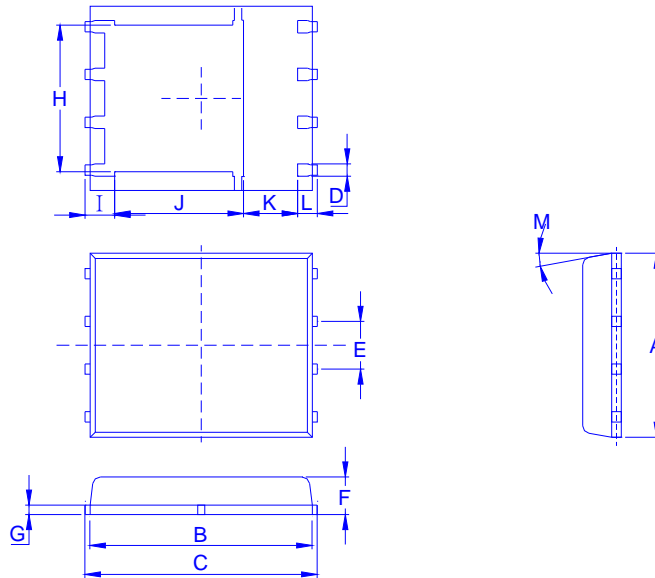
TYPICAL CHARACTERISTICS







Outline Drawing



Dimension in mm

Dimension	A	B	C	D	E	F	G	H	I	J	K	L	M
Min.	4.80	5.50	5.90	0.3		0.85	0.15	3.67	0.41	3.38	0.94	0.45	0°
Typ.					1.27								
Max.	5.30	5.80	6.10	0.51		1.20	0.30	4.54	0.78	3.92		0.71	12°

Recommended minimum pads

